

<b>Notice of References Cited</b>	Application/Control No. <b>09/276,346</b>	Applicant(s)/Patent Under Reexam <b>Senthil K. Viswanathan et al.</b>	
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**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	5,436,886	7/1994 <b>95</b>	McGill	370	219
B	5,398,236	<del>8/1993</del> <b>3/1995</b>	Hemmady et al.	370	218
C	5,715,237	<del>8/1995</del> <b>2/1998</b>	Akiyoshi	370	228
D	5,959,972	<del>5/1997</del> <b>9/1999</b>	Hamami	370	228
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A	5,186,926	<del>12/1990</del> 11/1992	Cisneros et al.	370	392
B	6,075,767	<del>3/1997</del> 6/2000	Sakamoto et al.	370	228
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B	5,903,544	<del>4/1997</del> 5/1999	Sakamoto et al.	370	218
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